

**Search Notes**

Application/Control No.

10/627,742

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

AOTSUKA, YASUO

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	8/7/2007	NT
348/223.1, 222.1, 273-280, 294, 370 (text search - see search history printout)	8/10/2007	NT
Text search all databases listed above.	8/10/2007	NT